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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1

of 2

Complete if Known		
Application Number	10/599,227	
Filing Date	09/22/2006	
First Named Inventor	POWER, Joan F.	
Art Unit		
Examiner Name		
Attorney Docket Number	773/14555.3	

U. S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.1	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant
		Number-Kind Code ^{2 (F known)}			Figures Appear
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FOREIGN PATENT DOCUMENTS						
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Substitute for form 1449/PTO	Complete if Known		
	Application Number	10/599,227	
INFORMATION DISCLOSURE	Filing Date	09/22/2006	
STATEMENT BY APPLICANT	First Named Inventor	POWER, Joan F.	
(Use as many sheets as necessary)	Art Unit		
(USE as many sheets as necessary)	Examiner Name		
Sheet 2 of 2	Attorney Docket Number	773/14555.3	

Examiner	Cite	NON PATENT LITERATURE DOCUMENTS Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of	-
Initials*	No.1	the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	C1	FU, S.W. et al., "Broadband Light Profile Microscopy: A Rapid and Direct Method for Thin Film Depth Imaging", :96-104	
	C2	POWER, Joan F. et al., "Longitudinal Light Profile Microscopy: A New Method for Seeing Below the Surfaces of", Applied Spectroscopy (1999) Vol. 53(12):1507-1519	
	СЗ	POWER, Joan F. et al., "Dual Beam Light Profile Microscopy: A New Technique for Optical", Applied Spectroscopy (2004) Vol. 58(2):166-178	
	C4	POWER, J.F., "Fresnel diffraction model for the point spread of a laser light profile microscope (LPM)", Appl. Phys. B 78 (2004), pp. 693-703	
_	C5	SMITH, Warren J., Modern Optical Engineering: The Design of Optical Systems, Second Edition, 1990, pp. 270-278, McGraw-Hill, New York.	
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